

Notice of References Cited

Application/Control No.

10/017,318

Applicant(s)/Patent Under
Reexamination
HONG, JOON KI

Examiner

Nathan W. Ha

Art Unit

2814

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,380,615	04-2002	Park et al.	257/666
	B	US-2002/0008309 A1	12-1998	AKIYAMA, MITSUKUNI	257/686
	C	US-2001/0026013 A1	05-2001	Mess et al.	257/686
	D	US-2002/0121687 A1	03-2002	Winderl, Johann	257/686
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 06112461 A	04-1994	Japan	KANEDA et al.	H01L 27/14
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.